

Search Notes

Application/Control No.

10/769,047

Examiner

B. Chen

Applicant(s)/Patent under
Reexamination

HERNER ET AL.

Art Unit

1762

SEARCHED

Class	Subclass	Date	Examiner
427	255.39 255.393	2/1/2006	BC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	2/1/2006	BC
discussed defective oath issue with SPE Meeks and QAS Gorgos	2/1/2006	BC